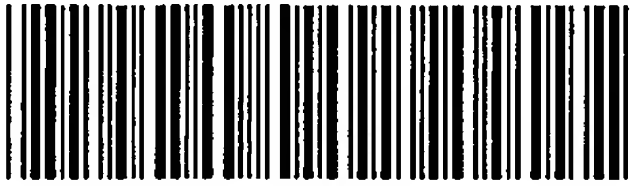


| | | | |
|--|-------------------------|---|--|
| <div>Search Notes</div> <div></div> | Application/Control No. | Applicant(s)/Patent under Reexamination | |
| | 10/649,124 | SAIKA ET AL. | |
| | Examiner | Art Unit | |
| | Michael Le | 2163 | |

| SEARCHED | | | |
|----------|----------|-----------|----------|
| Class | Subclass | Date | Examiner |
| 707 | 104.1 | 9/16/2005 | ML |
| 707 | 204 | 9/16/2005 | ML |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

| INTERFERENCE SEARCHED | | | |
|-----------------------|----------|------|----------|
| Class | Subclass | Date | Examiner |
| | | | |
| | | | |
| | | | |
| | | | |

| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | |
|---|-----------|------|
| | DATE | EXMR |
| Inventor Name Search | 9/12/2005 | ML |
| PLUS search through EIC | 9/12/2005 | ML |
| Searched EAST with key words and concepts | 9/16/2005 | ML |
| Searched NPL (Google, ACM) with key words | 9/16/2005 | ML |
| | | |
| | | |
| | | |
| | | |